

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10590632	JENSEN ET AL.
	Examiner	Art Unit
	Young J Kim	1637

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
Patent Databases (USPT, USPPG, EPO, JPO, DERWENT, IBM-TDB)	9/15/2008	/YJK/
see enclosed for text-search strategy	9/15/2008	/YJK/
updated - patent databases search - see enclosed for text-search strategy	5/13/2009	/YJK/
updated - patent databases search - see enclosed for text-search strategy	3/9/2010	/YJK/
updated	6/19/2010	/YJK/

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
	Interference search - see enclosed for search strategy	3/9/2010	/YJK/

	/Young J Kim/ Primary Examiner.Alt Unit 1637
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